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ATERNATIC STANDARD thor INTERNATIONAL

Optical amplifiers - Test methods

Optical amplifiers – Test methods
Part 1-1: Power and gain parameters – Optical spectrum analyzer method



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Part 1-1: Power and gain parameters— Optical spectrum analyzer method

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

OPTICAL AMPLIFIERS - TEST METHODS -

Part 1-1: Power and gain parameters – Optical spectrum analyzer method

FOREWORD

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International Standard IEC 61290-1-1 has been prepared by subcommittee 86C: Fibre optic systems and active devices, of IEC technical committee 86: Fibre optics.

This third edition cancels and replaces the second edition published in 2006 and constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) updates on the characteristics of measurement apparatus;
- b) revised list of addressed optical amplifier parameters.

The text of this standard is based on the following documents:

| FDIS | Report on voting |
|---------------|------------------|
| 86C/1309/FDIS | 86C/1328/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This standard shall be used in conjunction with IEC 61290-1 and IEC 61291-1.

A list of all parts of the IEC 61290 series, published under the general title *Optical amplifiers* – *Test methods* ¹ can be found on the IEC website.

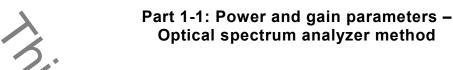
The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed.
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date

The first editions of some of these parts were published under the general title *Optical fibre amplifiers – Basic specification* or *Optical amplifier test methods*.

OPTICAL AMPLIFIERS - TEST METHODS -



1 Scope

This part of IEC 61290 applies to all commercially available optical amplifiers (OAs) and optically amplified modules. It applies to OAs using optically pumped fibres (OFAs based on either rare-earth doped fibres or on the Raman effect), semiconductor OAs (SOAs) and planar optical waveguide amplifiers (POWAs).

The object of this standard is to establish uniform requirements for accurate and reliable measurements, by means of the optical spectrum analyzer test method, of the following OA parameters, as defined in IEC 61291-1:

- a) nominal output signal power
- b) gain;
- c) polarization-dependent gain;
- d) maximum output signal power;
- e) maximum total output power.

NOTE All numerical values followed by (‡) are suggested values for which the measurement is assured.

The object of this standard is specifically directed to single-channel amplifiers. For multichannel amplifiers, one should refer to the IEC 61290-10 series [1]².

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61290-1, Optical amplifiers - Test methods - Part 1: Power and gain parameters

IEC 61291-1, Optical amplifiers - Part 1: Generic specification

3 Terms, definitions and abbreviations

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 61291-1 apply

3.2 Abbreviations

ASE amplified spontaneous emission

DBR distributed Bragg reflector (laser diode)

DFB distributed feed-back (laser diode)

² Numbers in square brackets refer to the Bibliography